

Notice of References Cited		Application/Control No. 10/613,495	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Pamela R. Schwartz	Art Unit 1774	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,485,812	11-2002	Sekiguchi, Hideki	428/32.29
	B	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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